Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,852	BARMAN ET AL:	
Examiner	Art Unit	
Tse Chen	2116	

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Class	Subclass	Date	Examiner
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INT	ERFERENC	E SEARCH	SEARCHED		
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
713/400 with "offset correction"	7/7/2007	тс			
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